

<b>Search Notes</b>				Application N .	Applicant(s)
				10/017,479	REENAN ET AL.
Examiner Jon M. Lockard Rachel B. Kapust				Art Unit 1647	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>	
Class	Subclass	Date	Examiner		DATE
530	350	9/25/2003	RBK	Searched Inventors in PALM, EAST, and STN	9/24/2003 RBK
424	9.1	9/25/2003	RBK	Searched SEQ ID NOS: 2, 3, 4, 5, and 6 in all databases except for pending database	9/25/2003 RBK
436	501	9/25/2003	RBK	Searched keywords in EAST and STN (medline, biosis, scisearch, caplue) (search results attached)	9/29/2003 RBK
<i>Name</i>		<i>8/17/05</i>	<i>JML</i>	<i>East Search ( USPAT, US-PGPUB, EPO, DERWENT): Text and Inventor's Name search. See Attached Search History</i>	<i>8/17/05 JML</i>
				<i>PALM: Inventor's Name Search</i>	<i>8/17/05 JML</i>
				<i>STN ( MEDLINE, SCISEARCH, EMBASE, BIOSIS ) Text and Inventor's Name search; See Attached Search History.</i>	<i>8/17/05 JML</i>
				<i>STIC Search of Seq ID NOS: 2-6 in Commercial and Patent Databases. See Attached Search Report</i>	<i>6/30/05 JML</i>
<b>INTERFERENCE SEARCHED</b>					
Class	Subclass	Date	Examiner		
<i>East Search ( USPAT, US-PGPUB, EPO, DERWENT): Text and Inventor's Name search. See Attached Search History</i>		<i>5/24/2006</i>	<i>JML</i>		
<i>PALM: Inventor Search</i>		<i>5/24/2006</i>	<i>JML</i>		
<i>STIC Search of Seq ID NOS: 2-3</i>		<i>5/24/2006</i>	<i>JML</i>		